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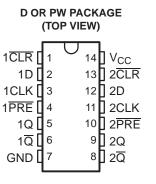
SCES481C-AUGUST 2003-REVISED APRIL 2008

DUAL POSITIVE-EDGE-TRIGGERED D-TYPE FLIP-FLOP WITH CLEAR AND PRESET

FEATURES

- Qualified for Automotive Applications
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Operates From 2 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max t_{pd} of 5.2 ns at 3.3 V
- Typical V_{OLP} (Output Ground Bounce) <0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- Typical V_{OHV} (Output V_{OH} Undershoot) >2 V at V_{CC} = 3.3 V, T_A = 25°C

DESCRIPTION/ORDERING INFORMATION



The SN74LVC74A-Q1 dual positive-edge-triggered D-type flip-flop is designed for 2.7-V to 3.6-V V_{CC} operation.

A low level at the preset (PRE) or clear (CLR) inputs sets or resets the outputs, regardless of the levels of the other inputs. When PRE and CLR are inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of this device as a translator in a mixed 3.3-V/5-V system environment.

ORDERING INFORMATION⁽¹⁾

T _A	PACKAG	6E ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 125°C	SOIC – D	Reel of 2500	SN74LVC74AQDRQ1	LVC74AQ
-40 0 10 1250	TSSOP – PW	Reel of 2000	SN74LVC74AQPWRQ1	LVC74AQ

For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI
web site at www.ti.com.

(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



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TEXAS INSTRUMENTS

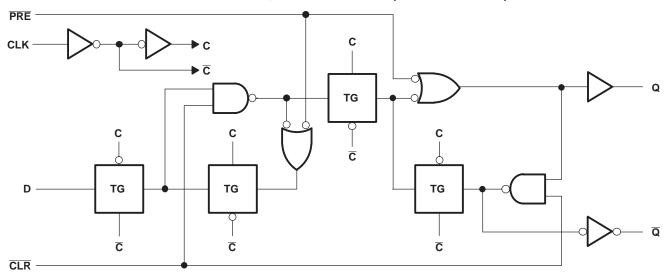
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INP	OUT	PUTS							
CLR	CLK	D	Q	Q					
Н	Х	Х	Н	L					
L	Х	Х	L	н					
L	Х	Х	H ⁽¹⁾	H ⁽¹⁾					
Н	↑	н	н	L					
Н	↑	L	L	н					
Н	L	Х	Q ₀						
	INP CLR H L L H H	INPUTS CLR CLK H X L X L X H ↑ H ↑	INPUTS CLR CLK D H X X L X X L X X H ↑ H H ↑ H H ↑ L	INPUTSOUTR \overline{CLR} CLK D Q HXXHLXXLLXXH(1)H \uparrow HHH \uparrow LLH \uparrow LL					

(1) This configuration is nonstable; that is, it does not persist when $\overline{\text{PRE}}$ or $\overline{\text{CLR}}$ returns to its inactive (high) level.

LOGIC DIAGRAM, EACH FLIP-FLOP (POSITIVE LOGIC)



FUNCTION TABLE

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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	6.5	V
VI	Input voltage range ⁽²⁾		-0.5	6.5	V
Vo	Output voltage range ⁽²⁾⁽³⁾		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
I _O	Continuous output current			±50	mA
	Continuous current through V_{CC} or GND			±100	mA
0	Deckage thermal impedance (4)	D package		86	°C/W
θ_{JA}	Package thermal impedance ⁽⁴⁾	PW package		113	-0/00
T _{stg}	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V_{CC} is provided in the recommended operating conditions table.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions⁽¹⁾

			MIN	MAX	UNIT
V	Supply voltogo	Operating	2	3.6	V
V _{CC}	Supply voltage	Data retention only	1.5		v
VIH	High-level input voltage	V_{CC} = 2.7 V to 3.6 V	2		V
VIL	Low-level input voltage	V_{CC} = 2.7 V to 3.6 V		0.8	V
VI	Input voltage		0	5.5	V
Vo	Output voltage		0	V_{CC}	V
	High-level output current	$V_{CC} = 2.7 V$		-12	mA
I _{OH}		$V_{CC} = 3 V$		-24	ША
	Low-level output current	$V_{CC} = 2.7 V$		12	mA
I _{OL}		$V_{CC} = 3 V$		24	ША
Δt/Δv	Input transition rise or fall rate			10	ns/V
T _A	Operating free-air temperature	Q suffix	-40	125	°C

 All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{cc}	MIN	TYP ⁽¹⁾ MAX	UNIT
	I _{OH} = -100 μA	2.7 V to 3.6 V	V _{CC} - 0.2		
V _{OH}	1. 10 m/	2.7 V	2.2		V
	$I_{OH} = -12 \text{ mA}$	3 V	2.4		
	$I_{OH} = -24 \text{ mA}$	3 V	2.2		
	I _{OL} = 100 μA	2.7 V to 3.6 V		0.2	
V _{OL}	I _{OL} = 12 mA	2.7 V		0.4	V
	I _{OL} = 24 mA	3 V		0.55	
l _l	$V_1 = 5.5 \text{ V or GND}$	3.6 V		±5	μA
I _{CC}	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	3.6 V		10	μA
ΔI _{CC}	One input at V_{CC} – 0.6 V, Other inputs at V_{CC} or GND	2.7 V to 3.6 V		500	μA
C _i	$V_1 = V_{CC} \text{ or } GND$	3.3 V		5	pF

(1) All typical values are at $V_{CC} = 3.3$ V, $T_A = 25^{\circ}C$.

Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			V _{CC} =	$V_{CC} = 2.7 V$		V _{CC} = 3.3 V ± 0.3 V	
			MIN	MAX	MIN	MAX	1
f _{clock}	Clock frequency			83		100	MHz
+	Pulse duration	PRE or CLR low	3.3		3.3		20
t _w		CLK high or low	3.3		3.3		ns
1	Setup time before CLKA	Data	3.4		3		20
t _{su}	Setup time before CLK↑	PRE or CLR inactive	2.2		2		ns
t _h	Hold time, data after CLK↑		1		1		ns

Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	2	FROM (INPUT)	TO (OUTPUT)	V _{CC} =	2.7 V	V _{CC} = 3 ± 0.3	3.3 V 5 V	UNIT
		(14-01)	(001F01)	MIN	MAX	MIN	MAX	
f _{max}				83		100		MHz
+		CLK	Q or Q		6	1	5.2	20
٩d		PRE or CLR			6.4	1	5.4	ns

Operating Characteristics

 $T_A = 25^{\circ}C$

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	PARAMETER	TEST CONDITIONS	V _{CC} = 2.5 V TYP	V _{CC} = 3.3 V TYP	UNIT
C _{pd}	Power dissipation capacitance per flip-flop	f = 10 MHz	47	51	pF

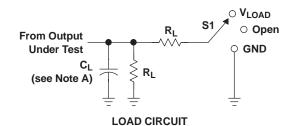
SN74LVC74A-Q1

TEXAS INSTRUMENTS

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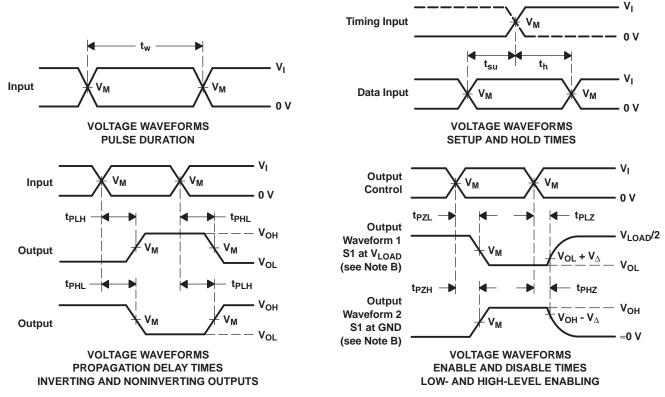
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PARAMETER MEASUREMENT INFORMATION



TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	V _{LOAD}
t _{PHZ} /t _{PZH}	GND

	N/	INF	PUTS	N	N/	•	-	N
	V _{CC}	VI	t _r /t _f	VM	V _{LOAD}	CL	RL	V _Δ
	2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3	$3 V \pm 0.3 V$	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_Q = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- D. The outputs are measured one at a time, with one transition
- E. t_{PLZ} and t_{PHZ} are the same as $t_{\text{dis}}.$
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74LVC74AQDRG4Q1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC74AQDRQ1	ACTIVE	SOIC	D	14	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-250C-1 YEAR
SN74LVC74AQPWRG4Q1	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC74AQPWRQ1	ACTIVE	TSSOP	PW	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74LVC74A-Q1 :

- Catalog: SN74LVC74A
- Enhanced Product: SN74LVC74A-EP
- Military: SN54LVC74A

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications

MECHANICAL DATA

MTSS001C - JANUARY 1995 - REVISED FEBRUARY 1999

PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



D (R-PDSO-G14)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.

Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.

E. Reference JEDEC MS-012 variation AB.



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